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**EIA-364-28F**

# **EIA STANDARD**

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## **TP-28F**

### **Vibration Test Procedure for Electrical Connectors and Sockets**

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## **EIA-364-28F**

(Revision of EIA-364-28E)

**January 2011**

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**Electronic Components Industry Association**

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(From Standards Proposal No. 5382.04, formulated under the cognizance of the CE-2.0 Committee on EIA National Connector and Sockets Standards)

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